Bonding, vibrational, and electrical characteristics of CdS nanostructures embedded in polyvinyl alcohol matrix

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CdS nanocomposites have been grown in polyvinyl alcohol matrix by a chemical synthesis process. The transmission electron micrographs of nanocomposites synthesized at 70–90 °C temperature showed the growth of needlelike and junctionlike nanostructures. X-ray photoelectron spectroscopy analysis revealed the growth of stoichiometric CdS without the formation of any intermediate phases at the CdS-polyvinyl alcohol interface. Raman spectra of first order longitudinal optical phonon peak has been analyzed using phonon dispersion model to detect the surface phonon modes in CdS nanoneedles and wires. The origin of negative differential resistance behavior in current-voltage characteristics for junctionlike CdS nanocomposites has been discussed. © 2009 American Institute of Physics. [DOI: 10.1063/1.3111971]

I. INTRODUCTION

Polymer inorganic–semiconductor nanocomposites have attracted much attention recently due to their unique size-dependent chemical and physical properties.1–5 Incorporation of zero dimensional and one dimensional nanostructures such as Q-dots and nanowires/nanotubes in polymer matrix is expected to enhance the functionality of composites. A lot of investigations have been carried out on the synthesis of low dimensional semiconductor nanostructures embedded in conducting as well as insulating polymer matrices for their possible applications in memories,6,7 light emitting diodes,8 high efficiency solar cells,9 and different sensing devices.10 CdS nanostructures embedded in polymer matrix have been reported to exhibit excellent optical as well as electrical characteristics,6,7 which are attractive not only for fundamental physics but also for their possible applications in the next generation organic and flexible electronics. We have reported the formation of one dimensional junctionlike CdS nanostructures inside polyvinyl alcohol (PVA) with shapes varying from needle to wire with the increase in bath temperature. The local chemical bonding and semiconductor/polymer interface play a crucial role in determining the optical and electrical properties of nanocomposites. A detailed x-ray photoelectron spectroscopy (XPS) study has been carried for chemical analysis of the nanocomposite films. The paper presents the bonding, vibrational, and electrical characteristics of CdS-PVA nanocomposites grown at different bath temperatures. The origin of surface phonon modes in Raman spectra and negative resistance behavior in junctionlike nanocomposites is discussed.

II. EXPERIMENTAL

CdS nanocomposites were synthesized in polyvinyl alcohol matrix using a simple chemical bath deposition (CBD) technique.11 The nanocomposite films were grown on (100) p-Si (7–14 Ω cm) and commercially available indium tin oxide (ITO) coated glass substrates at different bath temperatures from 70–90 °C. A thick CdS film, as a control sample, was also deposited on ITO coated glass substrates by a CBD process. Microstructural studies of deposited films were performed using a transmission electron microscope (JEOL JEM-2100F) with an accelerating voltage of 200 kV. XPS measurements were carried out in an ultrahigh vacuum chamber of a Sciencia ESCA 300 photoelectron spectrometer with a base pressure of 1×10−6 mbar. The spectra were recorded at normal emission with Al Kα excitation (hν =1486.7 eV) take off angle 45° and an energy resolution of 0.4 eV. The energy was calibrated using C 1s (at 285 eV) of adventitious carbon as a reference. Raman spectroscopy of the nanocomposites was studied using a JASCO Corp., NRS-1000 system (power 0.1 mW and spot size 100 μm) with a laser of wavelength 532 nm. Aluminum electrodes of area 3.14×10−6 m² were thermally evaporated on nanocomposites and control films for electrical contacts. The current-voltage characteristics of the films were measured using a programmable Keithley-485 picoammeter and Advantest-R6144 constant dc voltage source.

III. RESULT AND DISCUSSIONS

Figure 1 shows the plane-view transmission electron micrographs (TEM) of CdS nanocomposite films grown at 70–90 °C bath temperature in PVA matrix. The micrographs clearly demonstrate the formation of isolated needlelike structures at 70 °C [Fig. 1(a)], Y- and T-junctionlike nanostructures at 80 °C [Fig. 1(b)] and junctionlike nanowires at 90 °C [Fig. 1(c)]. From the TEM micrographs, it is evident that as the bath temperature increases from 70 to 90 °C, the structure changes from isolated CdS nanoneedles to branched nanowires. The temperature dependent growth mechanism, optical, and dielectric properties of junctionlike CdS nanostructures have been discussed in detail in our previous paper.11
To investigate the chemical bonding of the nanocomposite samples, XPS was carried out at room temperature. The XPS survey scan of CdS-PVA nanocomposites grown at 70, 80, 85, and 90 °C bath temperatures is depicted in Fig. 2. At all growth temperatures, the elements Cd, S, Cl, N, C, and O are detected. The dominant source of carbon and oxygen impurities in nanocomposites is originated from the host matrix polyvinyl alcohol. Thiourea [(NH₂)₂CS], which was used in chemical reaction, may also be a potential source of C. The chlorine concentration in as-deposited CdS is due to the reagents CdCl₂ and NH₄Cl used for the preparation of CdS nanocomposites by CBD process. The nitrogen peak may be attributed to the urea [(NH₂)₂CO] formation during the chemical reaction process. Figure 3 presents the binding energy of Cd 3d photoelectrons of the nanocomposites grown at different temperatures. Each spectrum exhibits a doublet feature due to spin-orbit splitting resulting into 3d₃/₂ and 3d₅/₂ peaks with a spin-orbit separation of 7.0 eV. The binding energy of 3d₅/₂ and 3d₃/₂ electrons of CdS nanocomposites is found to be 405.5 and 412.5 eV, respectively, which correspond to Cd in stoichiometric CdS. Figure 4 shows the sulfur 2p spectrum of the nanocomposites, with inset representing the typical fitted spectrum of S 2p photoelectrons. The spectrum is deconvoluted into two Gaussian peaks, which are attributed to S 2p₁/₂ and S 2p₃/₂ levels due to spin-orbit interaction. For the 80 °C grown sample the S 2p₁/₂ and S 2p₃/₂ levels are situated at 163.0 and 162.4 eV, which corresponds to S comes from CdS. The absence of any intermediate phases at the semiconductor-PVA interface is apparent from the XPS analysis of Cd 3d and S 2p spectra. The chemical composition also remains the same in the studied growth temperature range. The results indicate that the PVA matrix does not alter the local chemical bonding in CdS nanostructures, which is an essential requirement for functional materials using inorganic-organic heterostructures.

Figure 5 shows the valence band spectra of CdS-PVA nanocomposites grown at 70 and 80 °C. The photoemission spectra of the nanocomposites is similar to the bulk CdS.
The peak at 11.4–11.9 eV is assigned to the shallow 4d cadmium core, whereas the broadened peak at ~5 eV is due to the valence band of the nanocomposites. The position of the valence band maxima ($E_{\text{VBM}}$) has been determined by linear extrapolation of the leading edge to the energy axis. The value of $E_{\text{VBM}}$ for the nanocomposites synthesized at 70 and 80 °C is found to be 2.4 and 1.9 eV, respectively. It is clear from the inset of the Fig. 5 that the $E_{\text{VBM}}$ is shifted to the lower energy value at a higher growth temperature. We observed an increase in optical band gap energy of the nanocomposites with decreasing growth temperatures, due to the formation of smaller crystallites. Therefore, the shift in valence band edge toward higher energy may be attributed to reduce size of CdS clusters at lower growth temperature, in agreement with the reported results.

Figure 6 shows the Raman spectra of CdS-PVA nanocomposites grown at different temperatures. Raman peaks at 300, 601, and 907 cm$^{-1}$, respectively, are attributed to the first, second, and third order longitudinal optical (LO) phonon vibrational modes of CdS. While the first two modes are prominent, the third order LO peak is relatively weak. However, as the growth temperature increases, the Raman peak broadening is reduced and intensity is enhanced due to improved crystallinity in corroboration with our reported x-ray diffraction results. The most interesting feature of the Raman spectra is the presence of an asymmetry in the first order LO peak at lower frequency region. It is well known that in a crystalline insulator or semiconductor, the observed Raman shifts usually correspond to the LO phonons; whereas the transverse optic (TO) and the surface optical (SO) phonon modes are suppressed because of the symmetry restrictions and their low intensities, respectively. However, in case of nanostructures, the quantum size effects as well as enhanced surface-to-volume ratio make the appearance of SO mode plausible. The SO phonon mode in nanocrystals appears in between the ($\omega_{\text{LO}}$) and ($\omega_{\text{TO}}$) phonon frequencies, resulting in an asymmetry in 1LO peak.

The SO phonon mode peak has been extracted by deconvoluting the characteristic 1LO peak with two Lorentzians, having integrated intensity given by

$$I(\omega) = \frac{A_{\text{SO}}\Gamma_{\text{SO}}}{(\omega_{\text{SO}} - \omega^2)^2 + (\Gamma_{\text{SO}}\omega)^2} + \frac{A_{\text{LO}}\omega\Gamma_{\text{LO}}}{(\omega_{\text{LO}} - \omega^2)^2 + (\Gamma_{\text{LO}}\omega)^2},$$

where $A_{\text{SO}}(\omega_{\text{LO}}, \omega_{\text{TO}})$ and $\Gamma_{\text{SO}}(\Gamma_{\text{LO}})$ are the oscillator strength, frequency, and line width of the modes corresponding to the shoulder (LO phonon), respectively. The parameters $A_{\text{LO}}$, $\omega_{\text{TO}}$, and $\Gamma_{\text{LO}}$ have been extracted by fitting two Lorentzians to the experimental data points. A typical fitted spectrum for the 90 °C grown sample is shown in the inset of Fig. 6 with the fitted curve to experimental points represented by the solid line, and dashed lines representing spectrum corresponding to individual modes. To assign the SO phonon mode, we consider the dispersion relation $\omega_{\text{SO}}(q)$ for an infinite long cylindrical wire, in the limit where the phonon wave vector $q \gg \omega/c$ (Refs. 21 and 22),

$$\omega_{\text{SO}}^2 = \omega_{\text{TO}}^2 + \frac{\omega_p^2}{\varepsilon_x + \varepsilon_m f(x)},$$

$$x = qr,$$

where $\omega_{\text{TO}}$ is the TO mode frequency at the zone center, $\omega_p$ is the screened ion plasma frequency given by

$$\omega_p^2 = \omega_{\text{TO}}^2 + \frac{\omega_{\text{LO}}^2}{\varepsilon_x}.$$
Table I: Surface phonon mode (ωSO) and LO phonon (ωLO) peak position at different growth temperatures. The peak positions have been extracted from the fitted parameters.

<table>
<thead>
<tr>
<th>Growth Temperature</th>
<th>Extracted values (ωSO cm⁻¹)</th>
<th>Extracted values (ωLO cm⁻¹)</th>
<th>Calculated values (ωSO cm⁻¹ (x−4))</th>
<th>Intensity</th>
<th>10^{-8}</th>
<th>10^{-7}</th>
<th>10^{-6}</th>
<th>10^{-5}</th>
<th>10^{-4}</th>
</tr>
</thead>
<tbody>
<tr>
<td>80 °C</td>
<td>257.2 ± 1.1</td>
<td>300.3 ± 0.1</td>
<td>7 e_m = 5.2  6.3 = 257.1</td>
<td>0.08</td>
<td>0.1</td>
<td>0.05</td>
<td>0.02</td>
<td>0.01</td>
<td>0.005</td>
</tr>
<tr>
<td>85 °C</td>
<td>262.1 ± 1.1</td>
<td>300.2 ± 0.1</td>
<td>6 e_m = 5.2  6.3 = 262.3</td>
<td>0.09</td>
<td>0.1</td>
<td>0.05</td>
<td>0.02</td>
<td>0.01</td>
<td>0.005</td>
</tr>
<tr>
<td>90 °C</td>
<td>267.6 ± 1.1</td>
<td>300.4 ± 0.1</td>
<td>5 e_m = 5.2  6.3 = 263.0</td>
<td>0.11</td>
<td>0.1</td>
<td>0.05</td>
<td>0.02</td>
<td>0.01</td>
<td>0.005</td>
</tr>
</tbody>
</table>

\[ \frac{\omega_{SO}^{2}}{\omega_{LO}^{2}} = \frac{e_{m}}{e_{l}}. \]  

The high and low frequency dielectric constants of CdS are taken as \( e_{m} = 5.2 \) and \( e_{l} = 8.9 \), respectively, whereas \( e_{m} \) of the dielectric constant of polyvinyl alcohol are varied from 5 to 8.  

The calculated values of SO phonon frequencies (\( \omega_{SO} \)) at different growth temperatures are summarized in Table I. Using the 1LO peak of nanocomposites from Fig. 6 and Eqs. (2)–(5), SO phonon frequencies (\( \omega_{SO}, x \sim 4 \)) are found to be at 257.1, 262.3, and 263.0 cm⁻¹ at growth temperatures of 80, 85, and 90 °C, respectively. This is an excellent agreement with the extracted \( \omega_{SO} \) of 257.2 and 262.1 for nanocomposites grown at 80 and 85 °C, respectively. The deviation of extracted \( \omega_{SO} \) (≈267.6 cm⁻¹) from the calculated one at 90 °C may be due to the modified dielectric characteristics of PVA, which depends on molecular weight, degree of polymerization, voids, discontinuities, and temperature. However, the intensity ratio of SO to LO mode \( I_{SO}/I_{LO} \) (Table I) shows increasing nature with growth temperature.

Figures 7 and 8 show I-V characteristics of nanocomposites deposited on ITO coated glass and p-Si substrates, respectively. Interestingly, a negative differential resistance (NDR) behavior is clearly observed at a certain bias voltage in both the samples. Inset of Fig. 7 represents the I-V characteristics of control CdS thin film deposited on ITO substrate without any NDR characteristics. This type of negative resistance behavior in I-V characteristics at room temperature has been reported in thinner (<10 nm) composite polymeric films. However, in our case the origin of the negative resistance behavior is attributed to the tunneling between the overlapping CdS nanowires embedded in the PVA matrix in a region outlined in TEM micrograph [Fig. 1(c)]. When the gap between two wires is low enough, the tunneling may take place exhibiting the negative resistance characteristics. The peak-to-valley current \( (I_{p}/I_{v}) \) and voltage ratio \( (V_{p}/V_{v}) \) of the ITO/CdS-PVA/Al device is calculated to be 1.7 and 0.54, respectively. The single negative resistance peak in Fig. 7 is due to the formation of a junction with a single tunneling barrier between two nanowires. On the other hand, the appearance of negative resistance characteristics in both the bias conditions in Fig. 8 indicates the formation of a double junction, giving rise to back-to-back tunnel diodes. This can only happen due to the formation of an additional tunnel junction between n-CdS/p-Si with a thin insulating PVA barrier. The efficacy of the insulating PVA as a barrier layer is supported by the XPS analysis of the nanocomposites showing an excellent interface between CdS nanowires and PVA. One of the junctions is forward biased for any biasing condition resulting in negative resistance peaks in both directions, as shown in the inset of Fig. 8. The peak-to-valley current \( (I_{p}/I_{v}) \) and voltage ratio \( (V_{p}/V_{v}) \) of the p-Si/CdS-PVA/Al device in positive and negative bias are found to be 11.1, 1.6, and 0.24, 0.41, respectively.

IV. CONCLUSIONS

In conclusion, we have grown junctionlike CdS nanostructures inside a polymer matrix using a simple chemical technique. The detailed XPS analysis indicated the absence of nonstoichiometric and intermediate phases at the semiconductor/PVA interface at different growth temperatures. The VBM shifts to a higher value with decreasing growth temperature due to smaller CdS nanoparticles in corroboration with the enhancement of optical band gap. The asymmetry in Raman spectra has been attributed to the presence of SO phonon mode in nanocomposites. The SO phonon peak for different growth temperatures agrees with the estimated ones using a phonon dispersion relation of a long cylindrical wire. The negative resistance behavior in I-V characteristics signifies the tunneling phenomena between nanowire junctions with an insulating PVA barrier.
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